

## 74LVX163 Low Voltage Synchronous Binary Counter with Synchronous Clear

### General Description

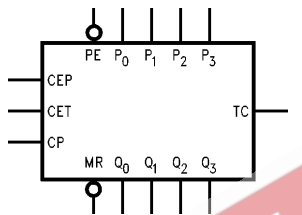
The LVX163 is a synchronous modulo-16 binary counter. This device is synchronously presettable for application in programmable dividers and has two types of Count Enable inputs plus a Terminal Count output for versatility in forming multistage counters. The CLK input is active on the rising edge. Both PE and CLR inputs are active on low logic levels. Presetting is synchronous to rising edge of CLK and the Clear function of the LVX163 is synchronous to CLK. Two enable inputs (ENP and ENT) and Carry Output are provided to enable easy cascading of counters, which facilitates easy implementation of n-bit counters without using external gates.

The inputs tolerate voltages up to 7V allowing the interface of 5V systems to 3V systems.

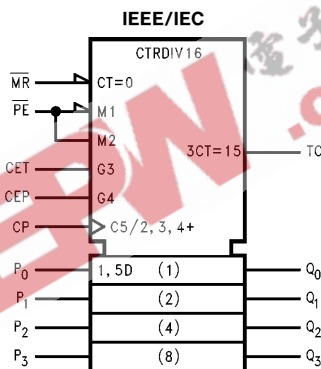
### Features

- Input voltage level translation from 5V to 3V
- Ideal for low power/low noise 3.3V applications
- Available in SOIC JEDEC, SOIC EIAJ, and TSSOP packages
- Guaranteed simultaneous switching noise and dynamic threshold performance

### Logic Symbols

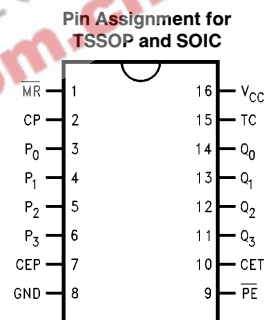


TL/F/12157-1



TL/F/12157-2

### Connection Diagram



TL/F/12157-3

	SOIC JEDEC	SOIC EIAJ	TSSOP
Order Number	74LVX163M 74LVX163MX	74LVX163SJ 74LVX163SJX	74LVX163MTC 74LVX163MTCX
See NS Package Number	M16A	M16D	MTC16

Pin Names	Description
CEP	Count Enable Parallel Input
CET	Count Enable Trickle Input
CP	Clock Pulse Input
MR	Synchronous Master Reset Input
P <sub>0</sub> -P <sub>3</sub>	Parallel Data Inputs
PE	Parallel Enable Inputs
Q <sub>0</sub> -Q <sub>3</sub>	Flip-Flop Outputs
TC	Terminal Count Output

## Functional Description

The LVX163 counts in modulo-16 binary sequence. From state 15 (HHHH) it increments to state 0 (LLLL). The clock inputs of all flip-flops are driven in parallel through a clock buffer. Thus all changes of the Q outputs occur as a result of, and synchronous with, the LOW-to-HIGH transition of the CP input signal. The circuits have four fundamental modes of operation, in order of precedence: synchronous reset, parallel load, count-up and hold. Four control inputs—Synchronous Reset ( $\overline{MR}$ ), Parallel Enable ( $\overline{PE}$ ), Count Enable Parallel (CEP) and Count Enable Trickle (CET)—determine the mode of operation, as shown in the Mode Select Table. A LOW signal on  $\overline{MR}$  overrides counting and parallel loading and allows all outputs to go LOW on the next rising edge of CP. A LOW signal on  $\overline{PE}$  overrides counting and allows information on the Parallel Data ( $P_n$ ) inputs to be loaded into the flip-flops on the next rising edge of CP. With  $\overline{PE}$  and  $\overline{MR}$  HIGH, CEP and CET permit counting when both are HIGH. Conversely, a LOW signal on either CEP or CET inhibits counting.

The LVX163 uses D-type edge-triggered flip-flops and changing the  $\overline{MR}$ ,  $\overline{PE}$ , CEP and CET inputs when the CP is in either state does not cause errors, provided that the recommended setup and hold times, with respect to the rising edge of CP, are observed.

The Terminal Count (TC) output is HIGH when CET is HIGH and counter is in state 15. To implement synchronous multi-stage counters, the TC outputs can be used with the CEP and CET inputs in two different ways.

Figure 1 shows the connections for simple ripple carry, in which the clock period must be longer than the CP to TC delay of the first stage, plus the cumulative CET to TC delays of the intermediate stages, plus the CET to CP setup time of the last stage. This total delay plus setup time sets the upper limit on clock frequency. For faster clock rates, the carry lookahead connections shown in Figure 2 are recommended. In this scheme the ripple delay through the intermediate stages commences with the same clock that causes the first stage to tick over from max to min in the Up mode, or min to max in the Down mode, to start its final cycle. Since this final cycle takes 16 clocks to complete, there is plenty of time for the ripple to progress through the intermediate stages. The critical timing that limits the clock period is the CP to TC delay of the first stage plus the CEP to CP setup time of the last stage. The TC output is subject to decoding spikes due to internal race conditions and is therefore not recommended for use as a clock or asynchro-

nous reset for flip-flops, registers or counters. When the Output Enable ( $\overline{OE}$ ) is LOW, the parallel data outputs  $O_0$ – $O_3$  are active and follow the flip-flop Q outputs. A HIGH signal on  $\overline{OE}$  forces  $O_0$ – $O_3$  to the High Z state but does not prevent counting, loading or resetting.

$$\text{Logic Equations: Count Enable} = \text{CEP} \cdot \text{CET} \cdot \overline{\text{PE}}$$

$$\text{TC} = Q_0 \cdot Q_1 \cdot Q_2 \cdot Q_3 \cdot \text{CET}$$

Mode Select Table

$\overline{MR}$	$\overline{PE}$	CET	CEP	Action on the Rising Clock Edge ( $\nearrow$ )
L	X	X	X	Reset (Clear)
H	L	X	X	Load ( $P_n \rightarrow Q_n$ )
H	H	H	H	Count (Increment)
H	H	L	X	No Change (Hold)
H	H	X	L	No Change (Hold)

H = HIGH Voltage Level  
L = LOW Voltage Level  
X = Immaterial

## State Diagram

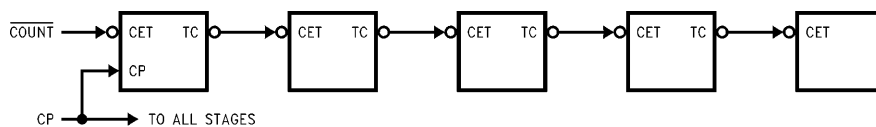
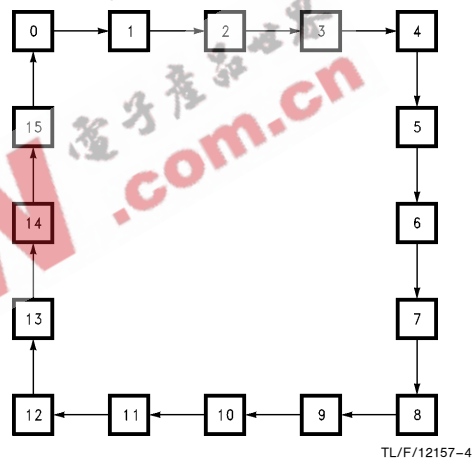


FIGURE 1

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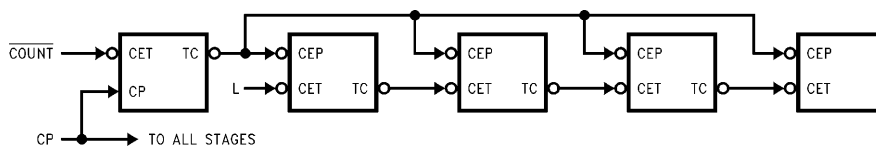
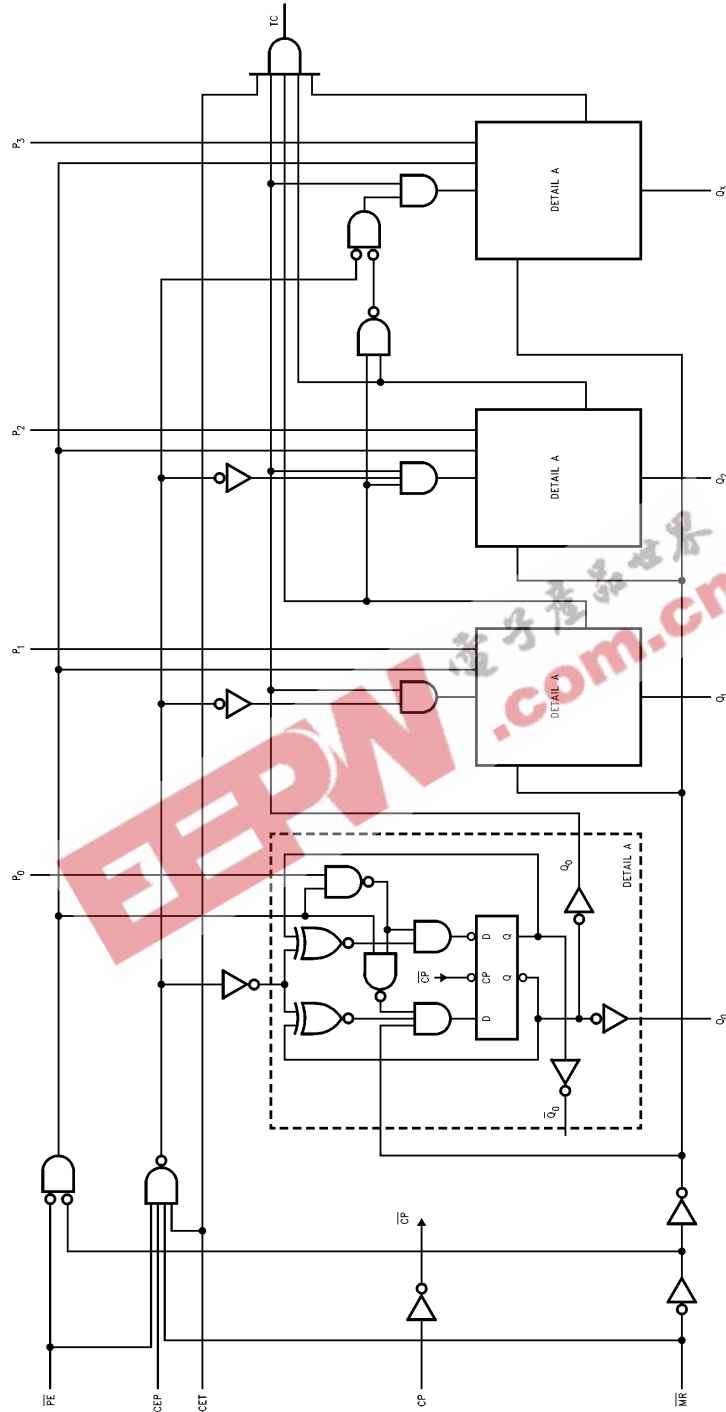


FIGURE 2

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# Block Diagram



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Please note that this diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

### Absolute Maximum Ratings (Note)

Supply Voltage ( $V_{CC}$ )	-0.5V to +7.0V
DC Input Diode Current ( $I_{IK}$ )	-20 mA
$V_I = -0.5V$	
DC Input Voltage ( $V_I$ )	-0.5V to 7V
DC Output Diode Current ( $I_{OK}$ )	-20 mA
$V_O = -0.5V$	
$V_O = V_{CC} + 0.5V$	+20 mA
DC Output Voltage ( $V_O$ )	-0.5V to $V_{CC} + 0.5V$
DC Output Source or Sink Current ( $I_O$ )	$\pm 25$ mA
DC $V_{CC}$ or Ground Current ( $I_{CC}$ or $I_{GND}$ )	$\pm 50$ mA
Storage Temperature ( $T_{STG}$ )	-65°C to +150°C
Power Dissipation	180 mW

Note: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the "Electrical Characteristics" table are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

### Recommended Operating Conditions

Supply Voltage ( $V_{CC}$ )	2.0V to 3.6V
Input Voltage ( $V_I$ )	0V to 5.5V
Output Voltage ( $V_O$ )	0V to $V_{CC}$
Operating Temperature ( $T_A$ )	-40°C to +85°C
Input Rise and Fall Time ( $\Delta t_r/\Delta t_f$ )	0 ns/V to 100 ns/V

### DC Electrical Characteristics

Symbol	Parameter	$V_{CC}$	74LVX163			74LVX163		Units	Conditions
			$T_A = +25^\circ\text{C}$			$T_A = -40^\circ\text{C to } +85^\circ\text{C}$			
			Min	Typ	Max	Min	Max		
$V_{IH}$	High Level Input Voltage	2.0 3.0 3.6	1.5 2.0 2.4			1.5 2.0 2.4	V		
$V_{IL}$	Low Level Input Voltage	2.0 3.0 3.6		0.5 0.8 0.8		0.5 0.8 0.8	V		
$V_{OH}$	High Level Output Voltage	2.0 3.0 3.0	1.9 2.9 2.58	2.0 3.0		1.9 2.9 2.48	V	$V_{IN} = V_{IL}$ or $V_{IH}$ $I_{OH} = -50 \mu\text{A}$ $I_{OH} = -50 \mu\text{A}$ $I_{OH} = -4 \text{mA}$	
$V_{OL}$	Low Level Output Voltage	2.0 3.0 3.0		0.0 0.0 0.36		0.1 0.1 0.44	V	$V_{IN} = V_{IL}$ or $V_{IH}$ $I_{OL} = 50 \mu\text{A}$ $I_{OL} = 50 \mu\text{A}$ $I_{OL} = 4 \text{mA}$	
$I_{IN}$	Input Leakage Current	3.6		$\pm 0.1$		$\pm 1.0$	$\mu\text{A}$	$V_{IN} = 5.5V$ or GND	
$I_{CC}$	Quiescent Supply Current	3.6		2.0		20.0	$\mu\text{A}$	$V_{IN} = V_{CC}$ or GND	

Noise Characteristics						
Symbol	Parameter	V <sub>CC</sub> (V)	LVX163		Units	C <sub>L</sub> (pF)
			T <sub>A</sub> = 25°C			
			Typ	Limits		
V <sub>OLP</sub> *	Quiet Output Maximum Dynamic V <sub>OL</sub>	3.3	0.2	0.5	V	50
V <sub>OLV</sub> *	Quiet Output Minimum Dynamic V <sub>OL</sub>	3.3	-0.2	-0.5	V	50
V <sub>IHD</sub> *	Minimum High Level Dynamic Input Voltage	3.3		2.0	V	50
V <sub>ILD</sub> *	Maximum Low Level Dynamic Input Voltage	3.3		0.8	V	50

\*Parameter guaranteed by design.

AC Electrical Characteristics									
Symbol	Parameter	V <sub>CC</sub> (V)	LVX163			LVX163		Units	Conditions
			T <sub>A</sub> = 25°C			T <sub>A</sub> = -40°C to +85°C			
			Min	Typ	Max	Min	Max		
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay Time (CP-Q <sub>n</sub> )	2.7	9.0	14.0	1.0	16.0	ns	C <sub>L</sub> = 15 pF	
			11.3	17.0	1.0	19.0		C <sub>L</sub> = 50 pF	
		3.3 ± 0.3	8.3	12.8	1.0	15.0	ns	C <sub>L</sub> = 15 pF	
			10.8	16.3	1.0	18.5		C <sub>L</sub> = 50 pF	
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay Time (CP-TC, Count)	2.7	9.5	14.3	1.0	16.7	ns	C <sub>L</sub> = 15 pF	
			12.5	18.5	1.0	20.5		C <sub>L</sub> = 50 pF	
		3.3 ± 0.3	8.7	13.6	1.0	16.0	ns	C <sub>L</sub> = 15 pF	
			11.2	17.1	1.0	19.5		C <sub>L</sub> = 50 pF	
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay Time (CP-TC, Load)	2.7	11.4	18.0	1.0	21.0	ns	C <sub>L</sub> = 15 pF	
			14.0	21.0	1.0	24.0		C <sub>L</sub> = 50 pF	
		3.3 ± 0.3	11.0	17.2	1.0	20.0	ns	C <sub>L</sub> = 15 pF	
			13.5	20.7	1.0	23.5		C <sub>L</sub> = 50 pF	
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay Time (CET-TC)	2.7	8.6	13.5	1.0	15.0	ns	C <sub>L</sub> = 15 pF	
			11.0	16.5	1.0	18.5		C <sub>L</sub> = 50 pF	
		3.3 ± 0.3	7.5	12.3	1.0	14.5	ns	C <sub>L</sub> = 15 pF	
			10.5	15.8	1.0	18.0		C <sub>L</sub> = 50 pF	
f <sub>max</sub>	Maximum Clock Frequency	2.7	75	115	65	MHz	C <sub>L</sub> = 15 pF		
			50	80	45		C <sub>L</sub> = 50 pF		
		3.3 ± 0.3	80	130	70	MHz	C <sub>L</sub> = 15 pF		
			55	85	50		C <sub>L</sub> = 50 pF		
C <sub>IN</sub>	Input Capacitance		4	10	10	pF	V <sub>CC</sub> = Open		
C <sub>PD</sub>	Power Dissipation Capacitance		23			pF	(Note 1)		

**Note 1:** C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation: I<sub>CC (opr)</sub> = C<sub>PD</sub> \* V<sub>CC</sub> \* f<sub>IN</sub> + I<sub>CC</sub>.  
When the outputs drive a capacitive load, total current consumption is the sum of C<sub>PD</sub> and ΔI<sub>CC</sub> which is obtained from the following formula:

$$\Delta I_{CC} = F_{CP} \cdot V_{CC} \left( \frac{C_{Q0}}{2} + \frac{C_{Q1}}{4} + \frac{C_{Q2}}{8} + \frac{C_{Q3}}{16} + \frac{C_{TC}}{16} \right)$$

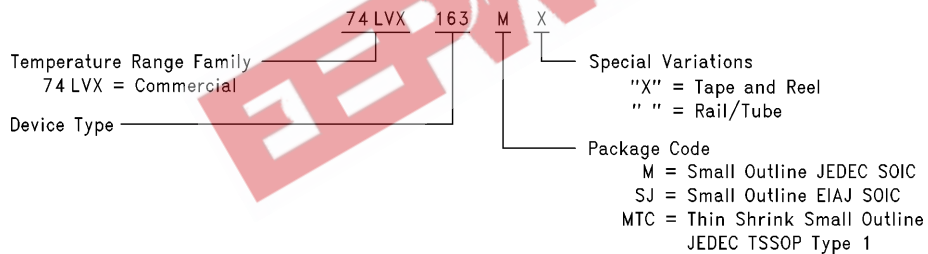
C<sub>Q0</sub>-C<sub>Q3</sub> and C<sub>TC</sub> are the capacitances at Q0-Q3 and TC, respectively. F<sub>CP</sub> is the input frequency of the CP.

## AC Operating Requirements

Symbol	Parameter	V <sub>CC</sub> (V)	LVX163	LVX163	Units	Conditions
			T <sub>A</sub> = 25°C	T <sub>A</sub> = -40°C to +85°C		
			Guaranteed Minimum			
t <sub>S</sub>	Minimum Setup Time (P <sub>n</sub> -CP)	2.7 3.3 ± 0.3	5.5 5.5	6.5 6.5	ns	
t <sub>S</sub>	Minimum Setup Time (PE-CP)	2.7 3.3 ± 0.3	8.0 8.0	9.5 9.5	ns	
t <sub>S</sub>	Minimum Setup Time (CEP or CET-CP)	2.7 3.3 ± 0.3	7.5 7.5	9.0 9.0	ns	
t <sub>S</sub>	Minimum Setup Time (MR-CP)	2.7 3.3 ± 0.3	4.0 4.0	4.0 4.0	ns	
t <sub>H</sub>	Minimum Hold Time (P <sub>n</sub> -CP)	2.7 3.3 ± 0.3	1.0 1.0	1.0 1.0	ns	
t <sub>H</sub>	Minimum Hold Time (PE-CP)	2.7 3.3 ± 0.3	1.0 1.0	1.0 1.0	ns	
t <sub>H</sub>	Minimum Hold Time (CEP or CET-CP)	2.7 3.3 ± 0.3	1.0 1.0	1.0 1.0	ns	
t <sub>H</sub>	Minimum Hold Time (MR-CP)	2.7 3.3 ± 0.3	1.5 1.5	1.5 1.5	ns	
t <sub>W(L)</sub> t <sub>W(H)</sub>	Minimum Pulse Width CP (Count)	2.7 3.3 ± 0.3	5.0 5.0	5.0 5.0	ns	

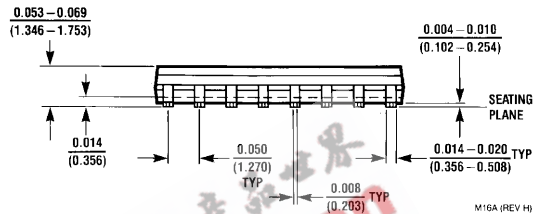
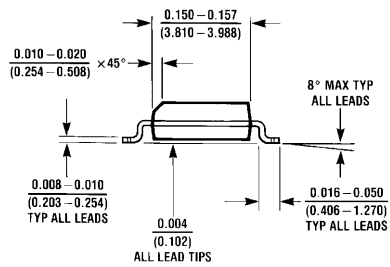
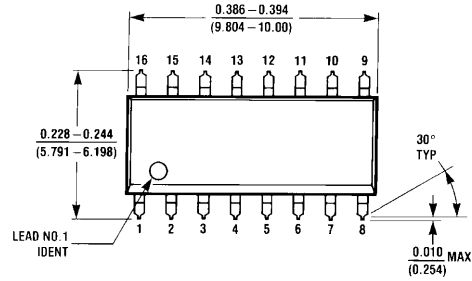
## Ordering Information

The device number is used to form part of a simplified purchasing code, where the package type and temperature range are defined as follows:

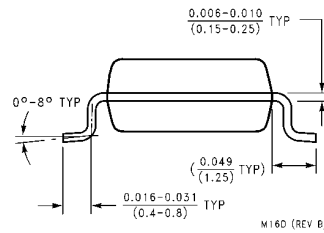
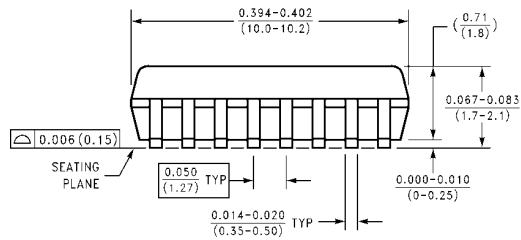
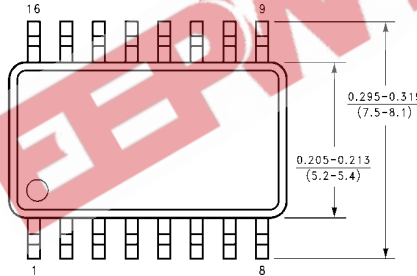


TL/F/12157-8

**Physical Dimensions** inches (millimeters) unless otherwise noted

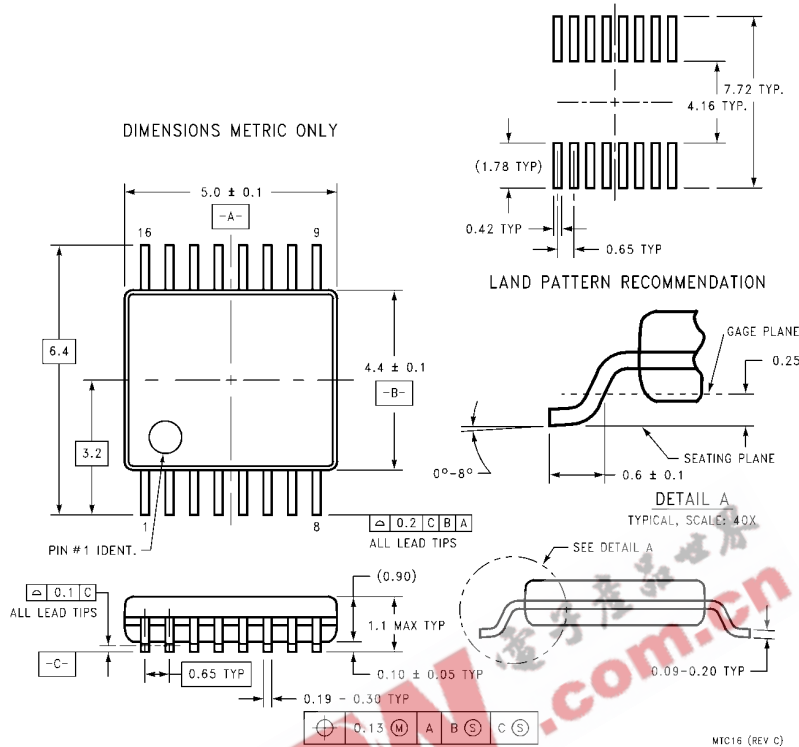


**16-Lead Molded JEDEC SOIC**  
**Order Number 74LVX163M**  
**NS Package Number M16A**



**16-Lead Molded EIAJ SOIC**  
**Order Number 74LVX163SJ**  
**NS Package Number M16D**

**Physical Dimensions** inches (millimeters) unless otherwise noted (Continued)



**16-Lead Molded JEDEC Type 1 TSSOP**  
**Order Number 74LVX163MTC**  
**NS Package Number MTC16**

MTC16 (REV C)

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